

N-Channel Silicon Carbide MOSFET

Rev.01 - 30 November 2022

Product data sheet

1. General description

Silicon Carbide MOSFET in a 3-lead TO247 plastic package, designed for high frequency, high efficiency systems.



2. Features and benefits

- Low on-resistance
- Fast switching speed
- 0V turn-off gate voltage for simple gate drive
- Easy to parallel
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- RoHS compliant

3. Applications

- Switch Mode Power Supplies
- UPS
- Solar string inverter and solar optimizer
- EV Charger
- Motor Drives

4. Quick reference data

Table 1. Q	uick reference data						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Absolute	maximum rating						
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	1200	V
I _D	drain current	V _{GS} = 20 V; T _{mb} = 25 °C		-	-	42	А
P _{tot}	total power dissipation	T _{mb} = 25 °C		-	-	230	W
Tj	junction temperature			-55	-	175	°C
Static ch	aracteristics	1					
$R_{\text{DS(on)}}$	drain-source on-state resistance	V _{GS} = 20 V; I _D = 20 A; T _j = 25 °C		-	80	98	mΩ
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_{\rm D}$ = 20 A; $V_{\rm DS}$ = 800 V; $V_{\rm GS}$ = 0V/20 V;		-	59	-	nC
Q _{GD}	gate-drain charge	T _j = 25 °C		-	11	-	nC
Source-c	Irain diode						
Q _r	recovered charge	$I_{SD} = 20 \text{ A}; \text{ di/dt} = 500 \text{ A/}\mu\text{s}; \text{ V}_{DS} = 400 \text{ V}; $ $T_j = 25 \text{ °C}$		-	108	-	nC

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5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		D
2	D	drain		
3	S	source		G_(I⊑,▲)
mb	D	mounting base; connected to drain		sym300 S

6. Ordering information

Table 3. Ordering information							
Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date	
WNSCM80120W	TO247	WNSCM80120W6Q	Tube	30	SOT429	25-Mar-2013	

7. Marking

Table 4. Marking codes						
Type number	Marking codes					
WNSCM80120W	WNSCM					
	80120W					

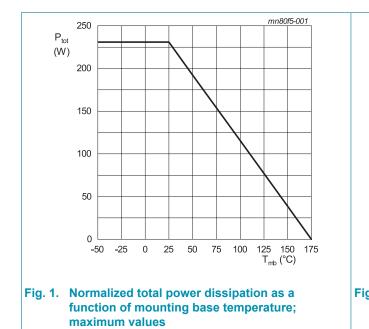
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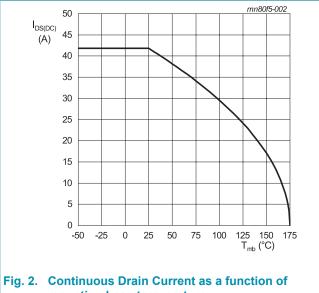
8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	1200	V
$V_{GS,max}$	gate-source voltage			-10	25	V
$V_{\text{GS,op}}$	gate-source voltage			-5	20	V
P _{tot}	total power dissipation	T _{mb} = 25 °C		-	230	W
I _D	drain current	V _{GS} = 20 V; T _{mb} = 25 °C		-	42	А
		V _{GS} = 20 V; T _{mb} = 100 °C		-	29	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$		-	81	А
E _{as}	single pulse drain-to- source avalanche	I_{AS} = 18 A; L = 1 mH; V _{DD} = 100 V, T _{j(init)} = 25 °C		162	-	mJ
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
$T_{sld(M)}$	peak soldering temperature			-	260	°C





mounting base temperature

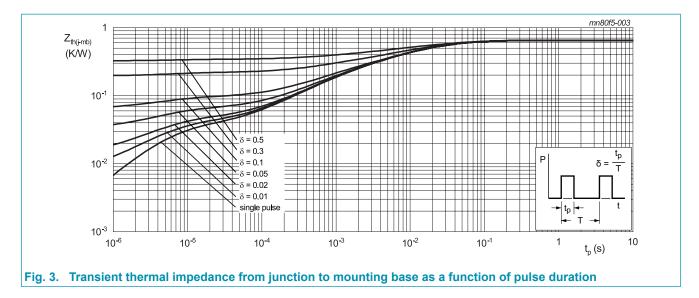
9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base			-	-	0.65	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W
M_{d}	Mounting torque	M3 or 6 - 32 screw		-	-	0.6	Nm

Note: It is recommended that a metal washer is inserted between screw head and mounting tab. Do not use self-tapping screws.

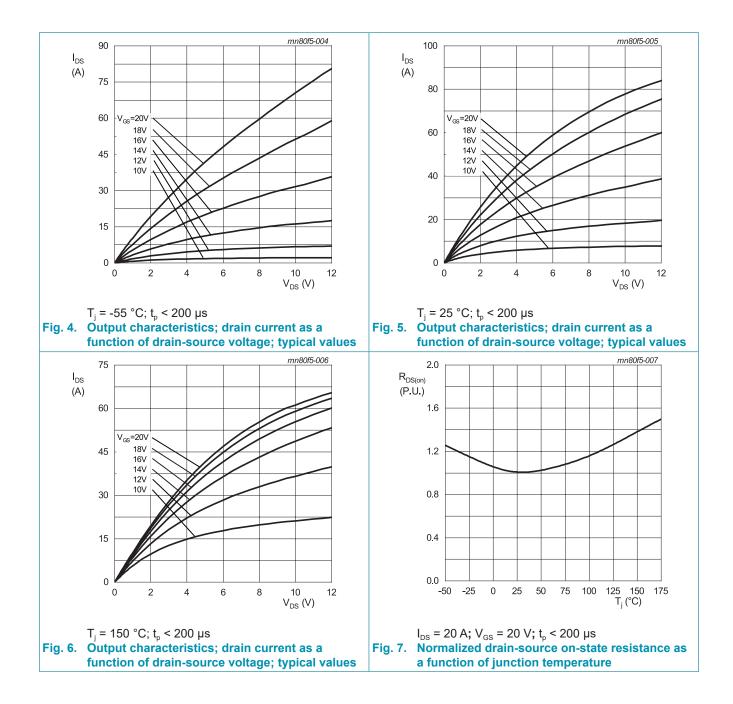
Device is ESD sensitive. Handling precautions are recommanded.

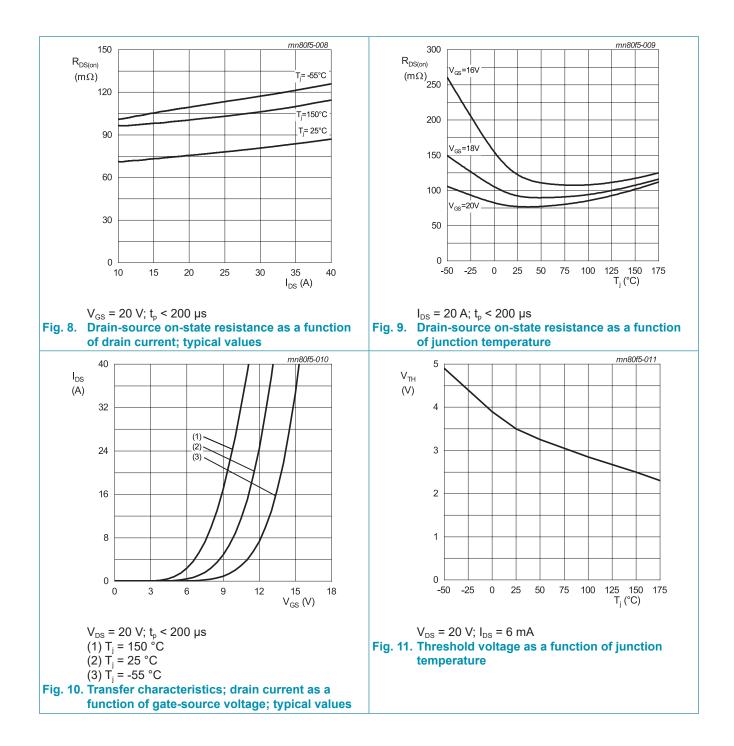


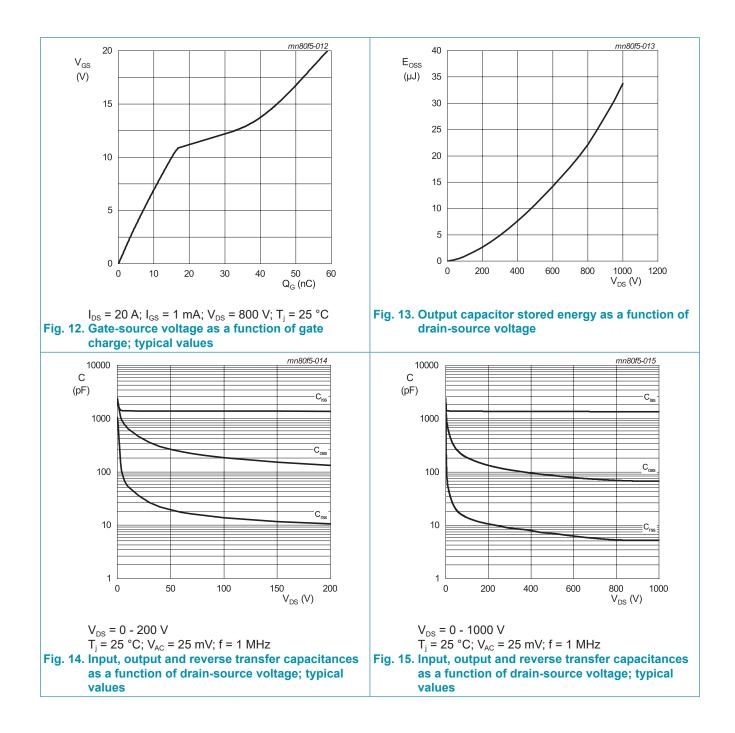
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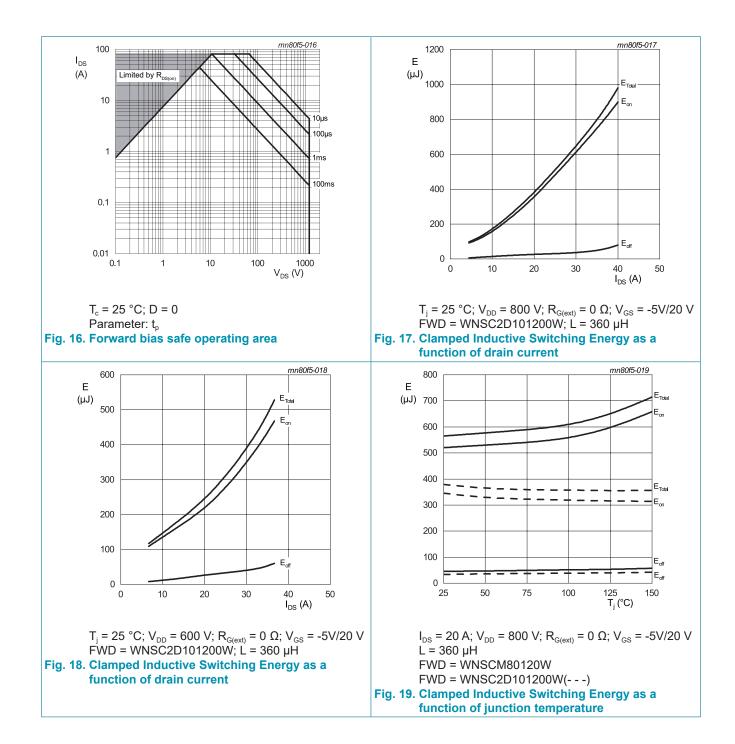
10. Characteristics

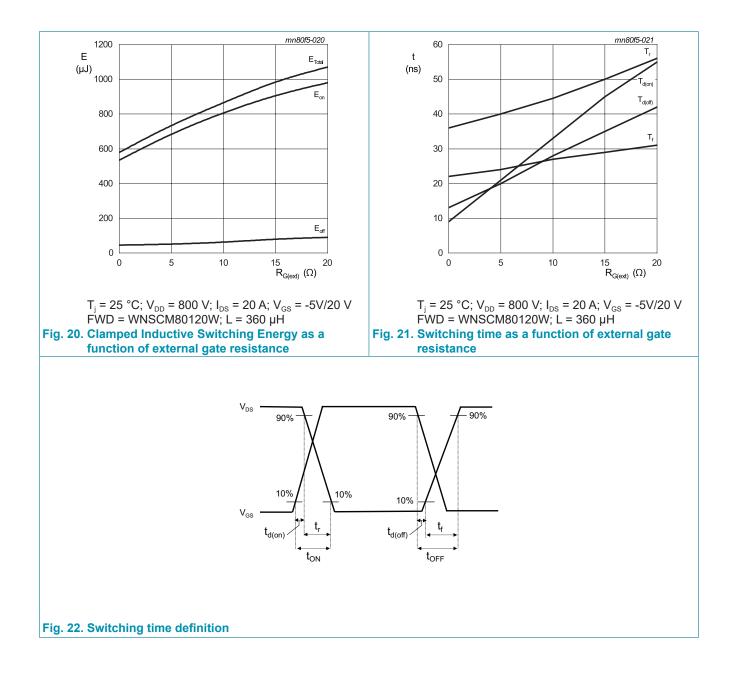
able 7. C	haracteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
V _{(BR)DSS}	drain-source breakdown voltage	I_{D} = 100 µA; V_{GS} = 0 V; T_{j} = 25 °C		1200	-	-	V
$V_{GS(th)}$	gate-source threshold	I_{D} = 6 mA; V_{DS} = 10 V; T_{j} = 25 °C		2.5	3.5	4.5	V
	voltage	I _D = 6 mA; V _{DS} = 10 V; T _j = 150 °C		-	2.5	-	V
I _{DSS}	drain leakage current	V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 25 °C		-	0.1	100	μA
	V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 150 °C		-	1	-	μA	
I _{GSS}	gate leakage current	V _{GS} = 25 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
R _{DS(on)}	drain-source on-state	V _{GS} = 20 V; I _D = 20 A; T _j = 25 °C		-	80	98	mΩ
	resistance	V _{GS} = 20 V; I _D = 20 A; T _j = 150 °C		-	110	-	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C		-	2.6	-	Ω
9 _{fs}	transconductance	V _{DS} = 20 V; I _D = 20 A; T _j = 25 °C		-	8.8	-	S
Dynamic	characteristics	I				1	
Q _{G(tot)}	total gate charge $I_D = 20 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = 0 \text{ V}/20 \text{ V};$			-	59	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C		-	23	-	nC
Q _{GD}	gate-drain charge			-	11	-	nC
C _{iss}	input capacitance	$V_{DS} = 1000 \text{ V}; V_{GS} = 0 \text{ V}; \text{ f} = 1 \text{ MHz};$ $T_j = 25 \text{ °C}$		-	1350	-	pF
C _{oss}	output capacitance			-	68	-	pF
C _{rss}	reverse transfer capacitance			-	5.5	-	pF
E _{oss}	Coss stored energy			-	34	-	μJ
t _{d(on)}	turn-on delay time	V_{DS} = 800 V; V_{GS} = -5/20 V; $R_{G(ext)}$ = 0 Ω ;		-	12	-	ns
t _r	rise time	I _D = 20 A; L = 360 μH; T _j = 25 °C		-	21	-	ns
t _{d(off)}	turn-off delay time			-	18	-	ns
t _f	fall time			-	18	-	ns
E _{on}	turn-on energy (SiC Diode FWD)			-	345	-	μJ
E _{off}	turn-off energy (SiC Diode FWD)			-	34	-	μJ
E _{on}	turn-on energy (Body Diode FWD)			-	520	-	μJ
E _{off}	turn-off energy (Body Diode FWD)			-	45	-	μJ
Source-d	Irain diode						
V_{SD}	source-drain voltage	$V_{GS} = 0 \text{ V}; \text{ I}_{F} = 10 \text{ A}; \text{ T}_{j} = 25 ^{\circ}\text{C}$		-	4.1	-	V
		$V_{GS} = 0 \text{ V}; \text{ I}_{F} = 10 \text{ A}; \text{ T}_{j} = 150 ^{\circ}\text{C}$		-	3.5	-	V
t _{rr}	reverse recovery time	$I_{SD} = 20 \text{ A}; \text{ di/dt} = 500 \text{ A/}\mu\text{s}; \text{ V}_{DS} = 400 \text{ V};$		-	36	-	ns
Q _r	recovered charge	T _j = 25 °C		-	108	-	nC
l _{rrm}	reverse recovery current			-	5.1	-	Α





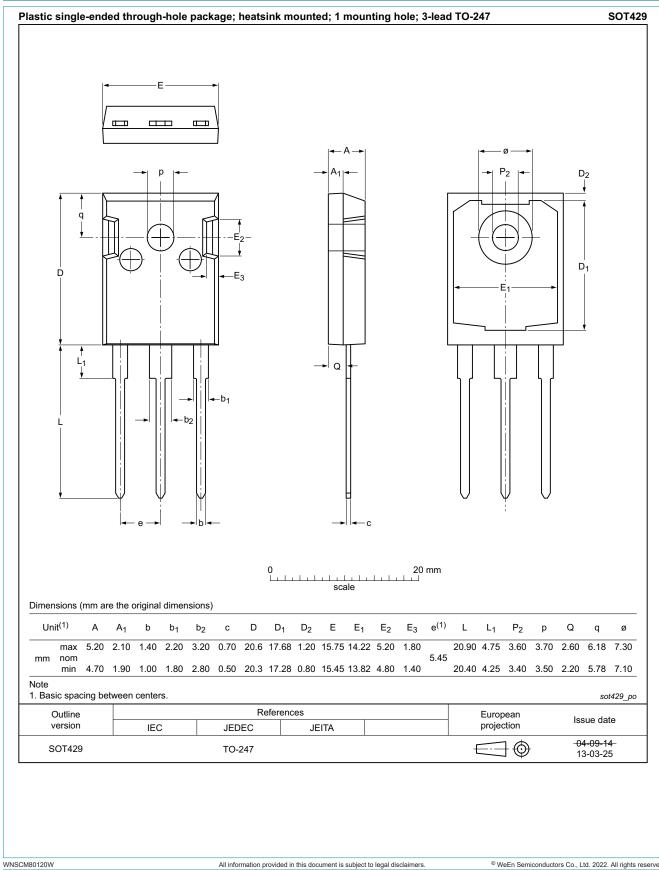






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11. Package outline



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12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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